

FAST • PRECISE • AFFORDABLE

3D CAMERA FOR MICROSCOPY

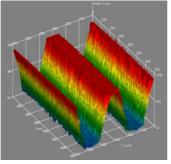
- 3D Surface Analysis
- Form & Roughness Measurement
- Automatic Depth Composition
- Z Depth Measurement



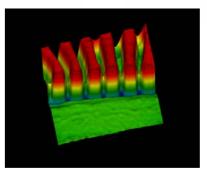
Compatible With Compound Microscopes & Stereo-Microscopes
Industrial Quality Control & Material Microscopy

Metal Paint Electronics Coatings Ceramic Polymers Semiconductor Materials Gemology Museum Forensics



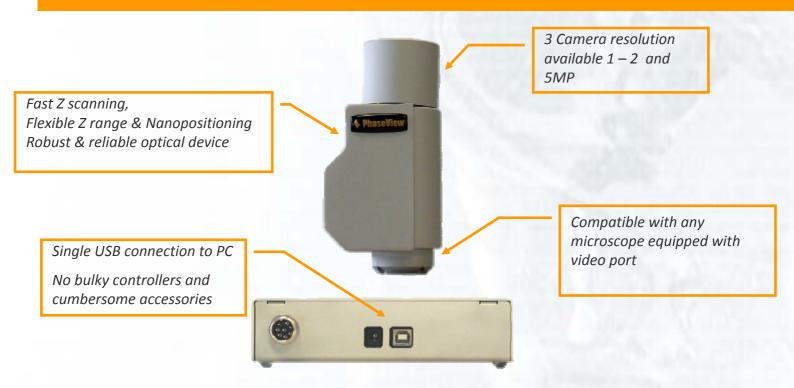












Use Video Port To Add 3D Imaging Capabilties

No objective or stage movement Sample space kept totally free No sample perturbation & vibrations No motorization: maintenance free No microscope adaptation required Do not alter standard camera use



ZeeCam on Upright Microscope



ZeeCam on Stereo Microscope

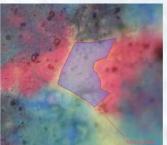


High Resolution Digital Microscope Camera

Megapixel CCD • 2D Measurements • Graphics Overlay • Report





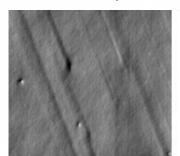


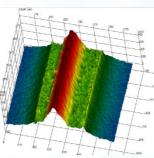


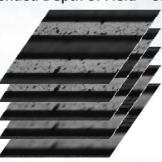
ZeeCam provides sharp & crisp digital images in real time, featuring all necessary tools for digital image documentation in high resolution.

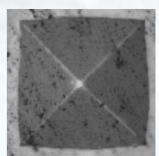
Multiple Imaging Capabilities

AutoFocus • Depth Measurement • Z-Stacking • Extended Depth of Field • 3D Reconstruction





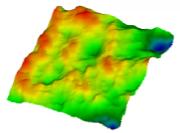


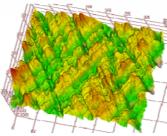


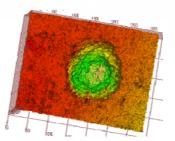
Thanks to its integrated ZeeScan module, the 3D camera performs all critical tasks in material microscopy while using a standard upright or inverted microscope.

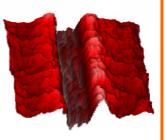
3D Surface Metrology

Surface Shape • Roughness • Waviness • Step Height









ZeeCam is the quickest and easiest way for precise surface topography measurements compared to complex, bulky and expensive systems.



Software

• GetPhase® GUI software (included) is compatible with Windows 8, 7, XP & Vista. GetPhase® provides comprehensive tools from automatic acquisition to 2D / 3D image analysis, documentation and reports. An optional API / SDK includes ZeeScan acquisition controls, routines for Z-stack, 3D reconstruction, EDF, DIC, Phase, and 3D surface analysis.

 Acquisition 	າ & Proc	essing
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2D/3D Display & Analysis

Image Data Export & Report

- 2D / 3D Acquisition Wizard - BF, DF, Ph, DIC, 3D views

- Auto Focus & Exposure

- Text & Graphics overlay

- Region-of-Interest

- 2D / 3D measurements

- Navigator

- Image fusion (EDF)

- Stitching

- Roughness ISO standards

- Macro Recording

- Step Height Measurements

- Project Archiving

- 3D Data in Excel Format

- 3D Data for 3rd Party Software

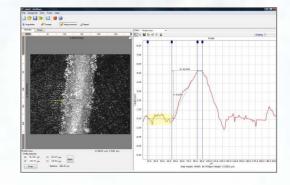
- Report Editor

- HTML Compatible Presentation

Powerful Imaging Tool

Z-stacking of high resolution images can be automatically achieved providing image fusion image (Extended depth of Fiel image, Z depth measurement or 3D reconstruction. In addition, GetPhase provides 2D measurements and image documentation tools.

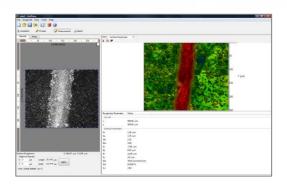
- Reveals finest structure details without specialized optics
- On click Image documentation with multiple views
- Automatic image fusion (Extended Depth of Field)
- 2D measurements & report



Fast & Accurate 3D Surface Metrology

ZeeScan with GetPhase performs 3D acquisition and analysis in a remarkable fast and easy way. Non contact optical surface profiling is highly repeatable.

- 3D surface analysis in micrometer and nanometer range
- Measurement capabilities from smooth to rough surfaces
- ISO Roughness and step heights measurements
- High throughput thanks to fast acquisition & processing time





Smart Hardware Architecture

No internal or external motorization, no additional accessories for the microscope are required, ZeeCam is connected to your PC using a single USB2 connection. Accurate calibration is achieved using an automated procedure and stored in an internal memory to prevent any losses.

Model	ZeeCam 100	ZeeCam 150	ZeeCam 200		
Camera	½"CMOS 1280 x 1024 5.2μm square pixels 30fps@full resolution	1/1.8"CCD 1616 x 1216 4.40 square pixels 12fps@full resolution	½"CCD 2560 x 1920 2.20 square pixels 6fps@full resolution		
Microscope interface	video Port – C-mount, recommended 1x c-mount coupler				
Dimensions & weight ZeeCam Head Control unit		155(H) 80(W) 56(D) mm 375 40(H) 158(W) 150(D) mm 150			
Power supply	110/220V AC				
PC interface	USB 2.0				

3D Measurement Performance

Z range and resolution are objective and c-mount coupler magnification dependant. The table here under gives typical performance for standard objective magnification with 1X coupler. For any other magnification and /or c-mount coupler configuration, the following formulas can be applied: Z Range = $16 \text{mm} / (G_Obj * G_adapt)^2$ Z Resolution = Objective Depth Of Field /4 $G_Obg = Objective magnification$ $G_adapt = c$ -mount coupler magnification

Objective Mag / NA	Z Range (μm)	Z Resolution (μm)	Z accuracy: 1%
5X / 0.10	640	0.32	Z Repeatability: 0.35%
10X / 0.25	160	0.08	Max slope: 90°
20X / 0.45	40	0.02	XY Spatial resolution determined by camera
50X / 0.8	6.4	0.003	resolution and objective magnification

Roughness Measurement

12 analysis parameters are provided in total, including the frequently-used Ra (Sa), Rq (Sq), Rz

(Sz), parameters. Parameters conform to ISO 4287, 25178 DIN 4768

Measuring range: Ra, Rq: 0.01-500μm Measuring accuracy: ≤±10% Repeatability: ≤6%

